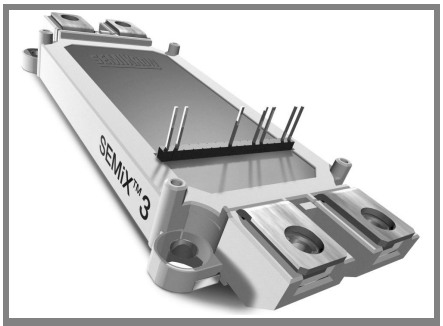
SEMiX 653GB176HD



SEMiX™ 3

Trench IGBT Modules

SEMiX 653GB176HD

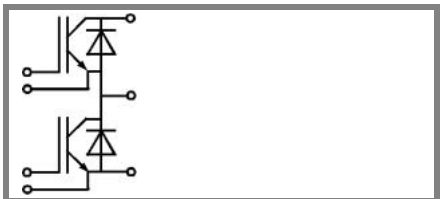
Target Data

Features

- Homogeneous Si
- Trench = Trenchgate technology
- $V_{CE(sat)}$ with positive temperature coefficient
- High short circuit capability

Typical Applications

- AC inverter drives
- UPS
- Electronic welders



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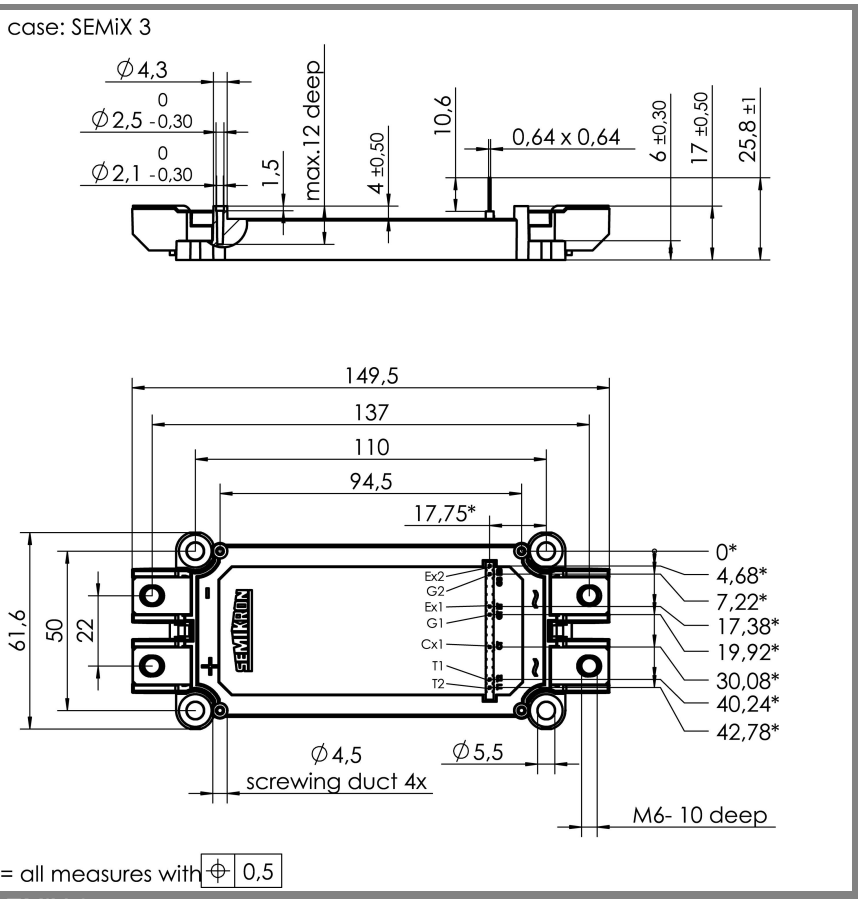
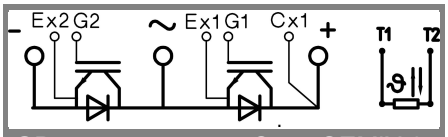
Absolute Maximum Ratings		T_c = 25 °C, unless otherwise specified	
Symbol	**Conditions**	**Values**	**Units**
IGBT			
V_{CES}		1700	V
I_C	T_c = 25 (80) °C	660 (470)	A
I_{CRM}	T_c = 25 (80) °C, t_p = 1 ms	1320 (940)	A
V_{GES}		± 20	V
T_{vj}, (T_{stg})	$T_{OPERATION} \leq T_{stg}$	- 40 ... + 150 (125)	°C
V_{isol}	AC, 1 min.	4000	V
Inverse diode			
I_F = - I_C	T_c = 25 (80) °C	450 (300)	A
I_{FRM}	T_c = 25 (80) °C, t_p = 1 ms	1320 (940)	A
I_{FSM}	t_p = 10 ms; sin.; T_j = 25 °C		A

Characteristics		T_c = 25 °C, unless otherwise specified			
Symbol	**Conditions**	**min.**	**typ.**	**max.**	**Units**
IGBT					
$V_{GE(th)}$	V_{GE} = V_{CE}, I_C = 18 mA	5,2	5,8	6,4	V
I_{CES}	V_{GE} = 0, V_{CE} = V_{CES}, T_j = 25 (125) °C			3,6	mA
$V_{CE(TO)}$	T_j = 25 (125) °C		1 (0,9)	1,2 (1,1)	V
r_{CE}	V_{GE} = 0 V, T_j = 25 (125) °C		2,2 (3,4)	2,8 (4)	mΩ
$V_{CE(sat)}$	I_C = 450 A, V_{GE} = 15 V, T_j = 25 (125) °C, chip level		2 (2,45)	2,45 (2,9)	V
C_{ies}	under following conditions		29,7		nF
C_{oes}	V_{GE} = 0, V_{CE} = 25 V, f = 1 MHz		1,7		nF
C_{res}			1,3		nF
L_{CE}			20		nH
$R_{CC'+EE'}$	resistance, terminal-chip, T_c= 25 (125) °C		0,8 (1,2)		mΩ
$t_{d(on)}$/t_r	V_{CC} = 1200 V, I_C = 450 A				ns
$t_{d(off)}$/t_f	V_{GE} = = ± 15 V				ns
E_{on} (E_{off})	R_{Gon} = R_{Goff} = 6,8 Ω, T_j = 125 °C		360 (170)		mJ
Inverse diode					
V_F = V_{EC}	I_F = 450 A; V_{GE} = 0 V; T_j = 25 (125) °C, chip level		2 (2,1)	2,2 (2,3)	V
$V_{(TO)}$	T_j = 25 (125) °C		1,1 (0,9)	1,3 (1,1)	V
r_T	T_j = 25 (125) °C		2 (2,7)	2 (2,7)	mΩ
I_{RRM}	I_F = 450 A; T_j = 25 (125) °C				A
Q_{rr}	di/dt = A/µs				µC
E_{rr}	V_{GE} = 0 V				mJ
Thermal characteristics					
$R_{th(j-c)}$	per IGBT			0,048	K/W
$R_{th(j-c)D}$	per Inverse Diode			0,12	K/W
$R_{th(j-c)FD}$	per FWD				K/W
$R_{th(c-s)}$	per module		0,04		K/W
Temperature sensor					
R_{25}	T_c = 25 °C		5 ±5%		kΩ
$B_{25/85}$	R_2=R_1exp[B(1/T_2-1/T_1)] ; T[K];B		3420		K
Mechanical data					
M_s/M_t	to heatsink (M5) / for terminals (M6)	3/2,5		5 /5	Nm
w			289		g



Case SEMiX 3



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This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

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